Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/502,390	HAYAKAWA ET AL.
Examiner	Art Unit
Todd E. Manahan	3732

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Class	Subclass .	Date	Examiner
132	112-116	11/28/2006	MV
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222	321.7		
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INT	INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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